Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/787,158	HAY ET AL.
Examiner	Art Unit
Anabel M. Ton	2875

	SEARCHED				
Class	Subclass	Date	Examiner		
428	1.1	1/24/2006	AT		
362	607				
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	1			

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